

IS1682E

■ Features

1. High speed response (Response frequency : MIN. 55MHz)
(Best suited for optical pick-up in X40 speed CD-ROM drive)
2. With built-in RF amplifier
(Integrates 6-division PIN photodiode and amplifier circuit onto a single chip)
3. Compact and thin package
(Dimensions : 5.0x4.0x1.5mm)
4. Possible to supply custom-made detecting patterns

■ Applications

1. CD-ROM drives (to X40 speed)
2. CD-ROM drives for CD-RW

■ Absolute Maximum Ratings

(Ta=25°C)

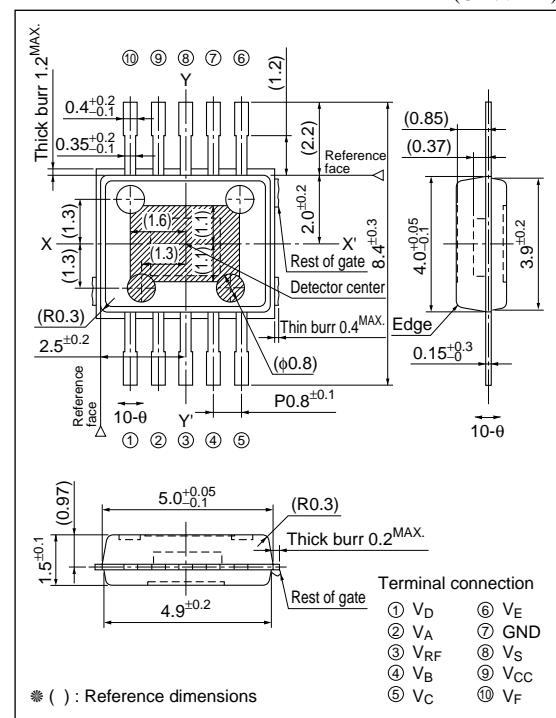
Parameter	Symbol	Rating	Unit
Supply voltage	VCC	6.0	V
* ¹ Output voltage	Vo	VCC	V
Operating temperature	Topr	-30 to +80	°C
Storage temperature	Tstg	-40 to +100	°C
* ² Soldering temperature	Tsol	260	°C

*¹ Applies to individual terminals of V_A, V_B, V_C, V_D, V_E, V_F, V_{RF}.*² For MAX. 3s at the position of 1.0mm from the resin edge.

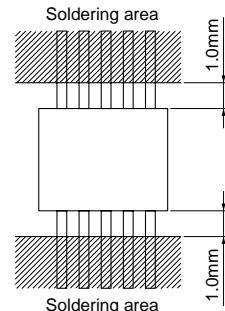
OPIC Light Detector for X40 Speed CD-ROM Drive / CD-RW Drive

■ Outline Dimensions

(Unit : mm)



* "OPIC"(Optical IC) is a trademark of the SHARP Corporation.
An OPIC consists of a light-detecting element and signal-processing circuit integrated onto a signal chip.



■ Recommended Operating Conditions (Ta=25°C)

Parameter	Symbol	MIN	TYP	MAX	Unit
Supply voltage	Vcc	4.5	5.0	5.25	V
Recommended supply voltage	Vcc	4.75	5.0	5.25	V
Operating supply voltage 1	Vs	2.0	2.1	2.2	V
Operating supply voltage 2	Vs	2.4	2.5	2.6	V

■ Electro-optical Characteristics 1-1

(Ta=25°C, Vcc=5V, Vs=2.1V, RL=10kΩ (VRF : Open), CL=10pF)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	Application
Supply current	Icc		8.8	14.8	20	mA	Vcc
Output off-set voltage 1	Vod1	Specified by voltage difference from Vs	-25	0	+25	mV	VA to VD
Output off-set voltage 2	Vod2	Specified by voltage difference from Vs	-15	0	+15	mV	VE, VF
Output off-set voltage 3	Vod3	GND Standard	1.25	1.4	1.55	V	VRF
Extremes of off-set voltage	ΔVod	A-B	-20	0	+20	mV	VA, VB
		C-D	-20	0	+20		VC, VD
		(A+C)-(B+D)	-20	0	+20		VA to VD
		E-F	-15	0	+15		VE, VF
		A+B+C+D	-40	+5	+50		VA to VD

■ Electro-optical Characteristics 1-2

(Ta=25°C, Vcc=5V, Vs=2.5V, RL=10kΩ (VRF : Open), CL=10pF)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	Application
Output off-set voltage 4	Vod4	Specified by voltage difference from Vs	-25	+2	+28	mV	VA to VD
Output off-set voltage 5	Vod5	Specified by voltage difference from Vs	-16	0	+16	mV	VE, VF
Output off-set voltage 6	Vod6	GND Standard	1.25	1.4	1.55	V	VRF
Extremes of off-set voltage	ΔVod	(A+C)-(B+D)	-22	0	+22	mV	VA to VD
		E-F	-15	0	+15		VE, VF
		A+B+C+D	-40	+13	+62		VA to VD

■ Electro-optical Characteristics 2

(Ta=25°C, Vcc=5V, Vs=2.1V, RL=10kΩ (VRF : Open), CL=10pF)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	Application
*3*4 Sensitivity 1	R _{p1}	—	18.0	24.6	31.2	mV/μW	V _A to V _D
*3*4 Sensitivity 2	R _{p2}	—	31.2	44.7	58.1	mV/μW	V _E , V _F
*3*4 Sensitivity 3	R _{p3}	—	30.2	43.2	56.1	mV/μW	V _{RF}
*5 Extreme of sensitivity	ΔR _p	—	—	—	10	%	—
Sensitivity ratio 1	R _{p2} /R _{p1}	—	—	1.81	—	—	—
Sensitivity ratio 2	R _{p3} /R _{p1}	—	1.67	1.76	1.84	—	—
*4*6*7 Response frequency 1	f _{c1}	-3dB	50	70	—	MHz	V _A to V _D
*4*6*7 Response frequency 2	f _{c2}	-3dB	55	72	—	MHz	V _{RF}
*4*6*7 Response frequency 3	f _{c3}	-3dB	1	5	—	MHz	V _E , V _F
*4*6*7 Response frequency 4	f _{c4}	Average of V _A to V _D	50	70	—	MHz	V _A to V _D
*4 High level output voltage 1	V _{OHI}	—	3.8	—	—	V	V _A to V _D
*4 High level output voltage 2	V _{OH2}	—	3.8	—	—	V	V _{RF}
*4*7*9 Sensitivity response 1	ΔR _{p1}	1MHz to 23.1MHz	-1.0	+1.0	+2.0	dB	V _A to V _D
*4*7*9 Sensitivity response 2	ΔR _{p2}	1MHz to 23.1MHz	-1.0	+1.0	+2.0	dB	V _{RF}
*4*7*10 Peaking rate 1	ΔR _{p3}	1MHz Standard	—	—	+3.0	dB	V _A to V _D
*4*7*10 Peaking rate 2	ΔR _{p4}	1MHz Standard	—	—	+3.0	dB	V _{RF}
*4*7 Group delay deviation 1	tgd1	f=1 to 23.1MHz, Average of V _A to V _D	—	2.5	5.5	ns	V _A to V _D
*4*7 Group delay deviation 2	tgd2	f=1 to 23.1MHz	—	2.5	5.5	ns	V _{RF}
Output noise level 1	V _{n1}	f=23.1MHz, BW=30kHz	—	-81	-76	dBm	V _A to V _D
Output noise level 2	V _{n2}	f=23.1MHz, BW=30kHz	—	-70	-65	dBm	V _{RF}
Extremes of off-set voltage	ΔV _{od}	A+B+C+D Ta=70°C	-60	+10	+100	mV	V _A to V _D
*8 Difference of output off-set voltage fluctuation temperature characteristics	TCΔV _{od}	(A+B)-(C+D) Ta=25°C to 70°C	-240	-30	+240	μV/°C	V _A to V _D
		E-F, Ta=25°C to 70°C	-150	+50	+150	μV/°C	V _E , V _F
*8 Output off-set voltage fluctuation temperature characteristics	TCV _{od}	GND reference, Ta=25°C to 70°C	—	+5	—	mV/°C	V _{RF}

*3 5μW, φ30μm of DC light is applied to the center of each photodiode.

Under that condition, sensitivity R is shown by following formula.

$$R_p = (V_p - V_{od}) / 5\mu W$$

V_p : Output voltage when DC light is applied.V_{od} : Output voltage when DC light is not applied.

*4 Light source : laser diode of λ=780nm

*5 Extreme of sensitivity is shown by following formula.

$$2 \times (R_{p1max} - R_{p1min}) / (R_{p1max} + R_{p1min}) \times 100$$

$$2 \times (R_{p2max} - R_{p2min}) / (R_{p2max} + R_{p2min}) \times 100$$

*6 Frequency sensitivity is -3dB. (reference sensitivity : value at f=1MHz) and fC4 is shown by following formula.

$$fC4 = (fCVA + fCVB + fCVC + fCVD) / 4$$

*7 In addition to 10μW, φ30μm DC light, 4μWp-p AC light is applied to the center of each photodiode. BW=10kHz

*8 Output off-set voltage deference temperature characteristics and

Output off-set voltage temperature characteristics shall be specified by following formula.

$$(\Delta V_{od}(70^\circ C) - \Delta V_{od}(25^\circ C)) / (70-25)$$

$$(V_{od}(70^\circ C) - V_{od}(25^\circ C)) / (70-25)$$

*9 When VCC is changed from 5V to 4.5V, the increase of sensitivity response is MAX, 0.5Bb.

*10 When VCC is changed from 5V to 4.5V, the increase of peaking rate is MAX, 1Bb.

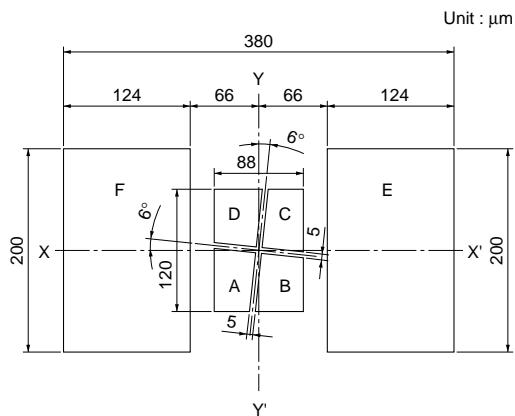
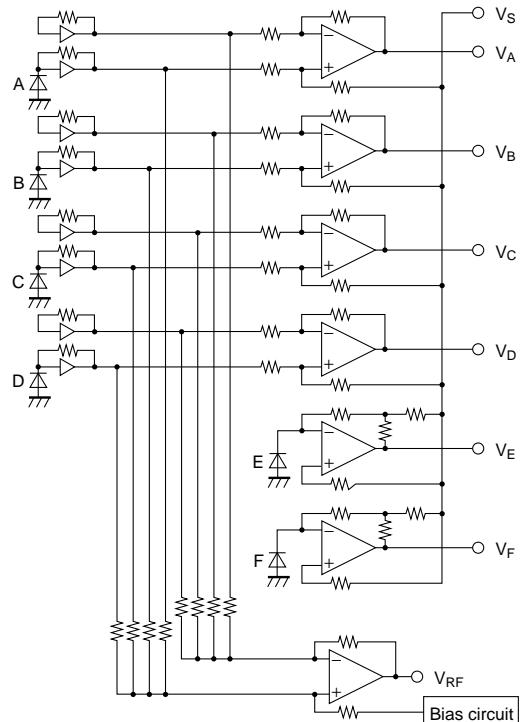
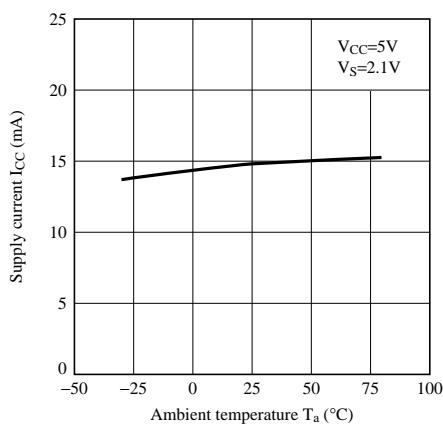
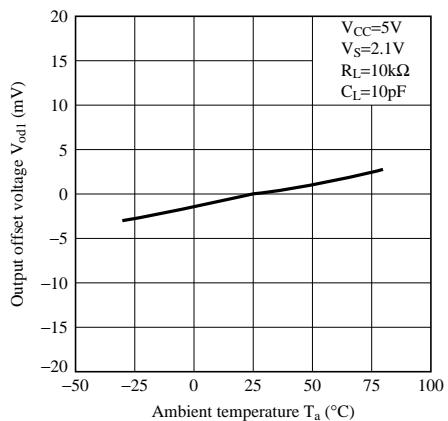
Fig.1 Detecting Pattern of Photodiode**Fig.2 Block Diagram****Fig.3 Supply Current vs. Ambient Temperature****Fig.4 Output Offset Voltage vs. Ambient Temperature (V_A to V_D)**

Fig.5 Output Offset Voltage vs. Ambient Temperature (V_E , V_F)

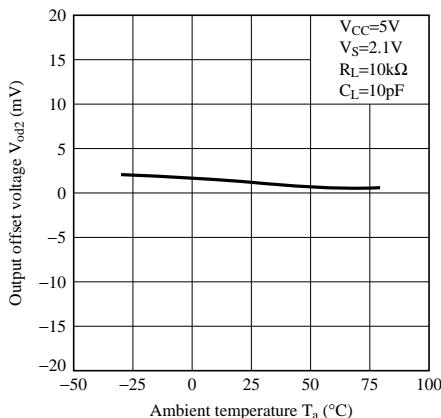


Fig.7 Response Frequency vs. Ambient Temperature (V_A to V_D)

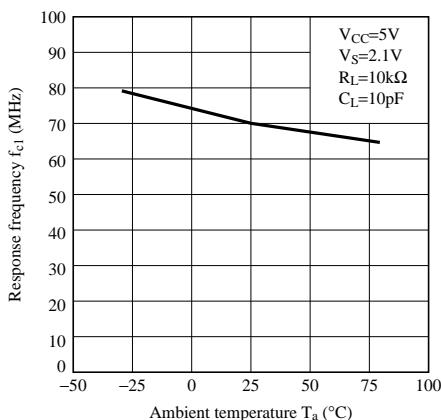


Fig.9 Sensitivity vs. Ambient Temperature (V_A to V_D)

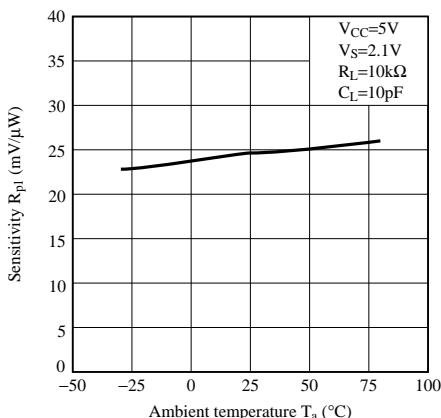


Fig.6 Output Offset Voltage vs. Ambient Temperature (V_{RF})

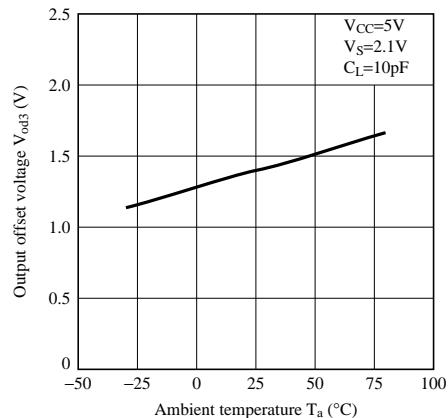


Fig.8 Response Frequency vs. Ambient Temperature (V_{RF})

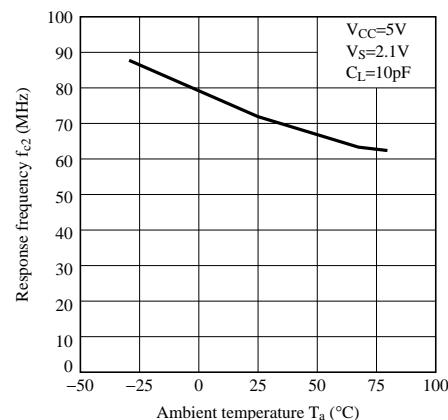


Fig.10 Sensitivity vs. Ambient Temperature (V_{RF})

